

<b>Form 1449 (Modified)</b>  <b>Information Disclosure Statement By Applicant</b>  (Use Several Sheets if Necessary)	<b>Atty. Docket No.</b> IBM1P036/SJ09-2003-0022US1	<b>Application No.:</b> 10/727,788
	<b>Applicant:</b> R. Biskeborn et al.	<b>Group Art Unit:</b> 3729
	<b>Filing Date:</b> 12/03/2003	

**U.S. Patent Documents**

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class	Filing Date
RST	A	5,883,770	03/16/1999	Biskeborn et al.	360	130.21	07/18/1997
RST	B	5,905,613	05/18/1999	Biskeborn et al.	360	130.21	07/18/1997
	C						
	D						
	E						
	F						
	G						
	H						
	I						
	J						
	K						

**Foreign Patent or Published Foreign Patent Application**

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
	L							
	M							
	N							
	O							
	P							

**Other Documents**

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
	R	
	S	
	T	
Examiner	<i>R.S. Tupper</i>	
	Date Considered	<i>7/06</i>

Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

<b>Form 1449 (Modified)</b>  <b>Information Disclosure Statement By Applicant</b>  (Use Several Sheets if Necessary)	Atty. Docket No. IBM1P036/ SJ09-2003-0022US1	Application No.: Unassigned
	Applicant: R. Biskeborn et al.	Group Art Unit: Unassigned
	Filing Date: Herewith	

#### U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class	Filing Date
RST	A	2002/0094758	07/18/2002	Reiley et al.	451	8	01/12/2001
	B	6,288,873	09/11/2001	Lundquist et al.	360	234.6	10/18/1999
	C	6,081,991	07/04/2000	Tsunoda et al.	29	603.08	09/10/1998
	D	5,749,769	05/12/1998	Church et al.	451	5	07/01/1996
	E	5,722,156	03/03/1998	Balfrey et al.	29	603.08	05/22/1995
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	G	4,624,048	11/25/1986	Hinkel et al.	29	603	08/06/1984
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